Supporting Information

for

Molecular Chemistry in a Zeolite:

Genesis of a Zeolite Y-supported Ruthenium Complex Catalyst

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EXAFS Data Analysis. Analysis of the EXAFS data was conducted with a difference file technique by use of the software XDAPW2 developed by Vaarkamp et al.¹ Each spectrum that was subjected to analysis was the average of four scans. Each spectrum was processed by fitting a second-order polynomial to the pre-edge region and subtracting this from the entire spectrum. The functional that was minimized and the function used to model the data are given elsewhere.² The background was subtracted by using cubic spline routines. Reference backscattering amplitudes and phase shifts were calculated with the software FEFF7³ from crystallographic data for representing the Ru– O and Ru–C contributions of I⁴; a RuAl alloy⁵ was used for Ru–Al contribution, and ruthenium metal was used for Ru–Ru contribution.⁵ Iterative fitting was done in *R* (distance) space. In the fitting, the coordination number *N* representing each contribution, the sigma-squared value $\Delta \sigma^2$, the interatomic distance *R*, and the inner potential correction ΔE_0 were varied until an optimized fit was obtained at each of four *k*weightings (k^0 , k^1 , k^2 , and k^3).

Errors were estimated on the basis of the standard equations:

$$\varepsilon^{2}_{\nu} = \frac{P}{NPTS(P-p)} \sum_{i}^{NPTS} \left(\frac{\chi_{i,\exp} - \chi_{i,\text{model}}}{\sigma_{i}}\right)^{2} \quad (1)$$

$$\text{variance} = \frac{\int [k^{n}(FT_{\text{model}}(R) - FT_{\exp}(R))]^{2} dR}{\int [k^{n}FT_{\exp}(R)]^{2} dR} \times 100 \quad (2)$$

where ε_v^2 is the goodness-of-fit parameter, *P* the total number of free parameters, *p* the number of free parameters, NPTS the actual number of points in the *k*-range used for analysis, and σ_i the measurement uncertainty for each data point, in the averaged spectrum.^{2,6} The absolute values of ε_v^2 often found in EXAFS analysis are approximately

10 and sometimes as much as several hundred, in part because estimation of the error σ_i is difficult, and thus ε_v^2 is not scaled well.⁷

We used the following procedure to discriminate between candidate models to represent the data. We checked whether the best-fit EXAFS parameters with each model were physically reasonable, discarding models with unrealistic EXAFS parameters. We examined fit quality, not just overall fit but also fits of individual contributions determined by using the difference file technique. We considered that one fit model with ε_{vl}^2 is significantly better than another model with ε_{v2}^2 only if the equation (3) is satisfied. The right-hand side of the equation (3) is two times the fluctuation of ε_v^2 .^{7,8}

$$(\varepsilon_{v_1}^2 - \varepsilon_{v_2}^2)/\varepsilon_{v_2}^2 > 2\sqrt{\frac{2}{P-p}}$$
 (3)

Peak deconvolution of IR spectra with Pearson VII model

The Pearson VII model is more general than Lorentzian or Gaussian functions. The Pearson VII distribution is shown below. When q approaches 1, the model resembles a Lorentzian in character and as q approaches infinity, it becomes Gaussian.

$$A_{i} = \sum_{j=1}^{b} \frac{a_{j}}{p \left(1 + \frac{(v_{i} - v_{j}^{0})^{2} (2^{1/q_{j}} - 1)}{p_{j}}\right)^{q_{j}}}$$

- *A_i*: values of absorbance predicted by band models
- *v_i*: *i*th wavenumber
- v_j^0 : peak center position of the *j*th band
- *b*: number of bands
- p_j : square of the half width at half-height
- q_j : band shape

Figure 1S. ¹H NMR spectrum characterizing I.

Figure 2S. ¹³C NMR spectrum characterizing I.

Figure 3S. Mass spectra characterizing the outlet gas stream during the treatment of Sample 1 in D₂. The blank data was collected with identical conditions without the sample. In both experiments, the signal intensities were normalized with respect to those for He (m/z = 4).

Figure 4S. IR spectra (from bottom to top: Ru(acac)₃, zeolite supported Ru(acac)₃, I, and Sample 1). The arrows indicate the band shifts for $v_{as}(CCC)_{ring}$.

Figure 5S. IR spectrum characterizing the silica supported ruthenium complex sample.

Figure 6S. Ru– C_1 phase- and amplitude- corrected k^1 -weighted FT magnitude and imaginary part of difference spectrum (solid line) and fit (dotted line) representing a Ru– C_1 contribution to the EXAFS data characterizing Sample 1 according to model **E**.

Figure 7S. Ru–Ru phase- and amplitude- corrected k^3 -weighted FT magnitude and imaginary part of difference spectrum (solid line) and fit (dotted line) representing a Ru–Ru contribution to the EXAFS data characterizing Sample 1 according to model **E**.

Figure 8S. Ru– C_1 phase- and amplitude- corrected k^1 -weighted FT magnitude and imaginary part of the difference spectrum (solid line) and fit (dotted line) representing Ru– C_1 contribution to the EXAFS data characterizing Sample 1 according to model **C**.

Figure 9S. Phase- and amplitude- corrected k^1 -weighted FT magnitudes and imaginary parts of the difference spectrum (solid lines) and fits representing each contribution (dotted lines) corresponding to structural parameters reported for model **F**.

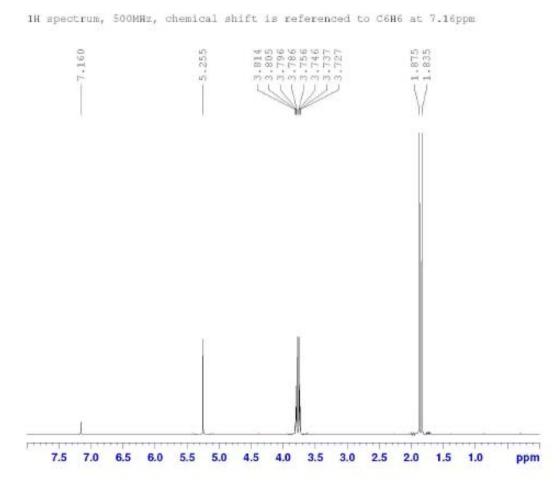
Figure 10S. IR spectrum characterizing Sample 1 (solid line) and spectral deconvolution (dashed line, fit; dotted line, component peaks).

Figure 11S. IR spectra of zeolite-supported ruthenium complexes with various loadings of ruthenium: solid line, 3 wt % loading; dashed line, 2 wt % loading; dotted line, 1 wt % loading.

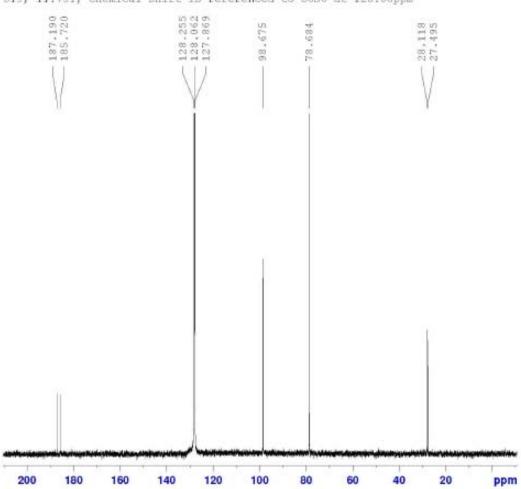
Figure 12S. IR spectrum characterizing zeolite-supported ruthenium complex with 2 wt % loading of ruthenium (solid line) and spectral deconvolution (dashed line, fit; dotted line, component peaks).

Figure 13S. IR spectrum characterizing zeolite-supported ruthenium complex with 3 wt % loading of ruthenium (solid line) and spectral deconvolution (dashed line, fit; dotted line, component peaks).









C13, 11.75T, chemical shift is referenced to C606 at 128.06ppm

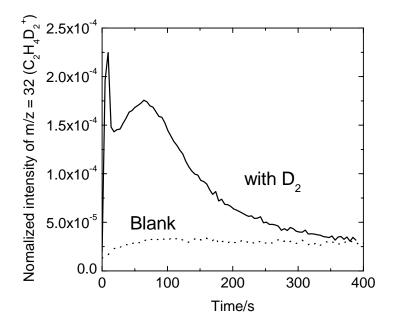


Figure 3S.

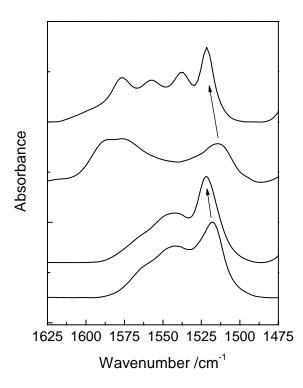


Figure 4S.

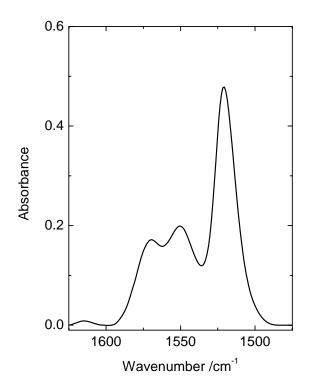


Figure 5S.

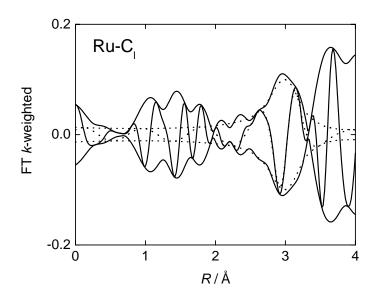


Figure 6S.

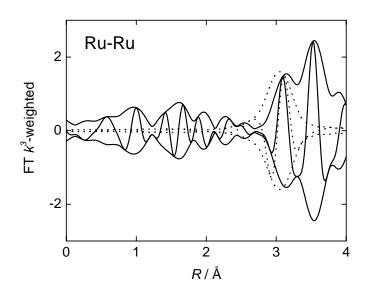


Figure 7S.

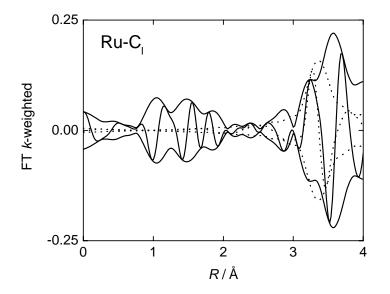
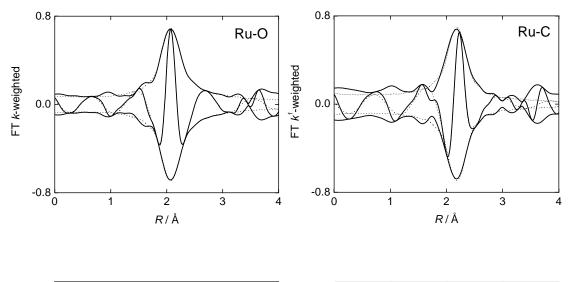


Figure 8S.



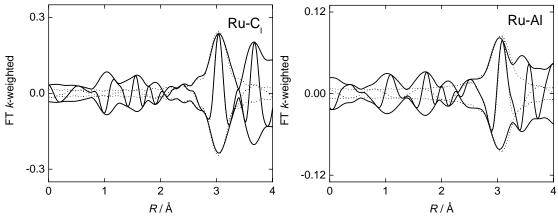


Figure 9S.

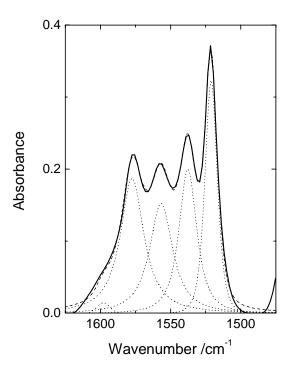


Figure 10S.

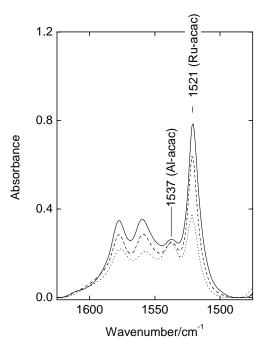


Figure 11S.

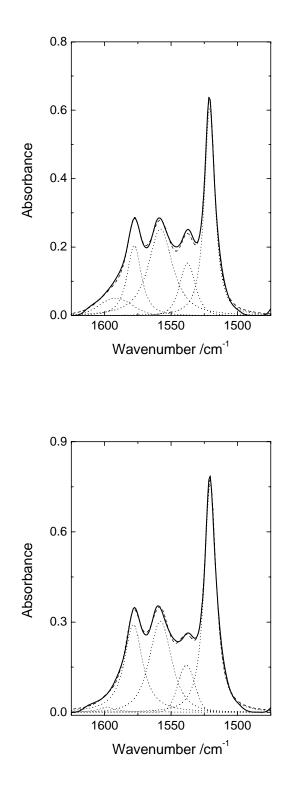


Figure 13S.

Figure 12S.

References

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